

N-Channel 40-V (D-S), 175 °C MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$R_{DS(on)}(\Omega)$	$I_D(\Omega)$ $I_D(A)^{a, c}$ Q_g			
40	0.016 at V _{GS} = 10 V	20	15.6 nC		
	$0.018 \text{ at V}_{GS} = 4.5 \text{ V}$	20	15.0110		

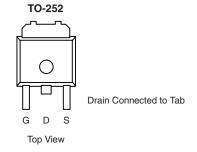
FEATURES

- TrenchFET® Power MOSFET
- 100 % R_g and UIS Tested

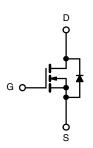


APPLICATIONS

- · LCD TV Inverter
- Secondary Synchronous Rectification



Ordering Information: SUD50N04-16P-E3 (Lead (Pb)-free)



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	T _A = 25 °C, unles	s otherwise no	oted	
Parameter		Symbol	Limit	Unit
Drain-Source Voltage	V_{DS}	40	V	
Gate-Source Voltage		V_{GS}		
	T _C = 25 °C		20 ^c	
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 100 °C		20 ^c	
Continuous Drain Current (1 _J = 150 °C)	T _A = 25 °C	I _D	9.8 ^b	
	T _A = 100 °C		6.8 ^b	A
Pulsed Drain Current		I _{DM}	50	^
Continuous Course Drain Diada Current	T _C = 25 °C		20 ^c	
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	2.5 ^b	
Single Pulse Avalanche Current	1 04 11	I _{AS}	20	
Avalanche Energy	L = 0.1 mH	E _{AS}	20	mJ
	T _C = 25 °C		35.7	
Maximum Power Dissipation	T _C = 100 °C	P _D	17.8	w
	T _A = 25 °C	7 ' ⁻ D	3.1 ^b	
	T _A = 100 °C		1.5 ^b	
Operating Junction and Storage Temperature Ra	T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^b	Steady State	R_{thJA}	40	50	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	3.4	5.3		

Notes:

- a. Based on $T_C = 25$ °C.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. Package limited.

SUD50N04-16P

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static						L	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V, } I_{D} = 250 \mu\text{A}$	40			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			38		1400	
$V_{GS(th)}$ Temperature Coefficient ΔV_{GS}		I _D = 250 μA		- 5.4		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	0.8		2.2	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 16 \text{ V}$			± 100	nA	
Zana Oata Valla aa Bair O	I _{DSS}	V _{DS} = 40 V, V _{GS} = 0 V			1	μΑ	
Zero Gate Voltage Drain Current		V _{DS} = 40 V, V _{GS} = 0 V, T _J = 100 °C			20		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
Drain-Source On-State Resistance ^a	Р	V _{GS} = 10 V, I _D = 15 A		0.0125	0.016	Ω	
	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$		0.014	0.018		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 15 A		58		S	
Dynamic ^b							
Input Capacitance	C _{iss}			1655		pF	
Output Capacitance	C _{oss}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		200			
Reverse Transfer Capacitance	C _{rss}			152			
Tatal Oata Obarra	0	$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 30 \text{ A}$		39.2	60	nC	
Total Gate Charge	Qg	V _{DS} = 20 V, V _{GS} = 4.5 V, I _D = 30 A		15.6	24		
Gate-Source Charge	Q_{gs}			4.2			
Gate-Drain Charge	Q_{gd}			5.5			
Gate Resistance	R_{g}	f = 1 MHz		2.1	3.2	Ω	
Turn-On Delay Time	t _{d(on)}			19	30	ns	
Rise Time	t _r	$\begin{aligned} V_{DD} &= 20 \text{ V, } R_L = 0.66 \ \Omega \\ I_D &\cong 30 \text{ A, } V_{GEN} = 4.5 \text{ V, } R_g = 1 \ \Omega \end{aligned}$		120	180		
Turn-Off Delay Time	t _{d(off)}			40	60		
Fall Time	t _f			36	55		
Turn-On Delay Time	t _{d(on)}			8	16		
Rise Time				22	35		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 30 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		24	36	-	
Fall Time	t _f			8	16		
Drain-Source Body Diode Characteris	tics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			20	А	
Pulse Diode Forward Current ^a	I _{SM}				50		
Body Diode Voltage	V_{SD}	I _S = 10 A		0.84	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			25	38	ns	
Body Diode Reverse Recovery Charge	Q_{rr}	$I_F = 20 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		22	33	nC	
Reverse Recovery Fall Time	t _a			15		ns	
Reverse Recovery Rise Time	t _b			10			

Notes:

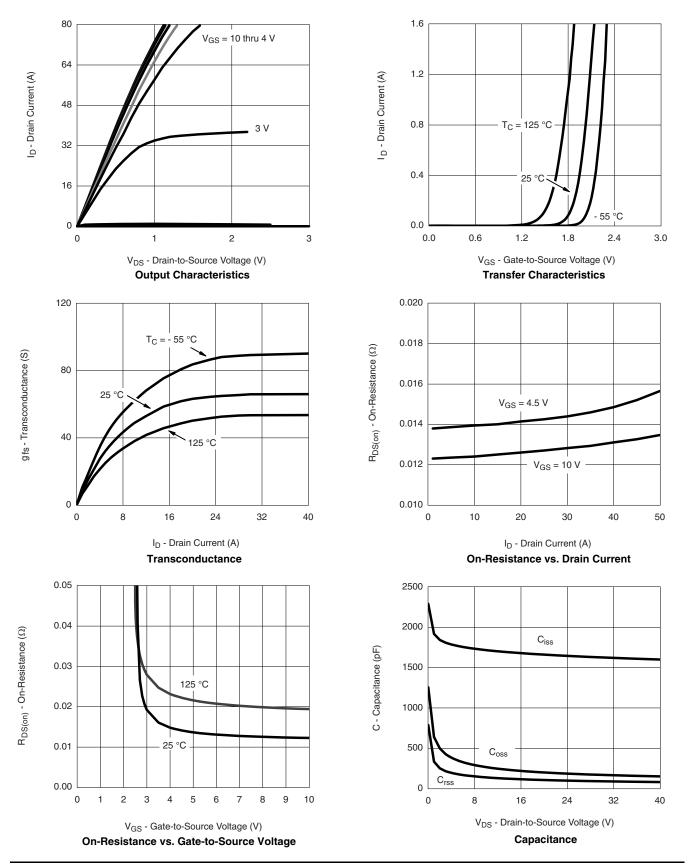
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

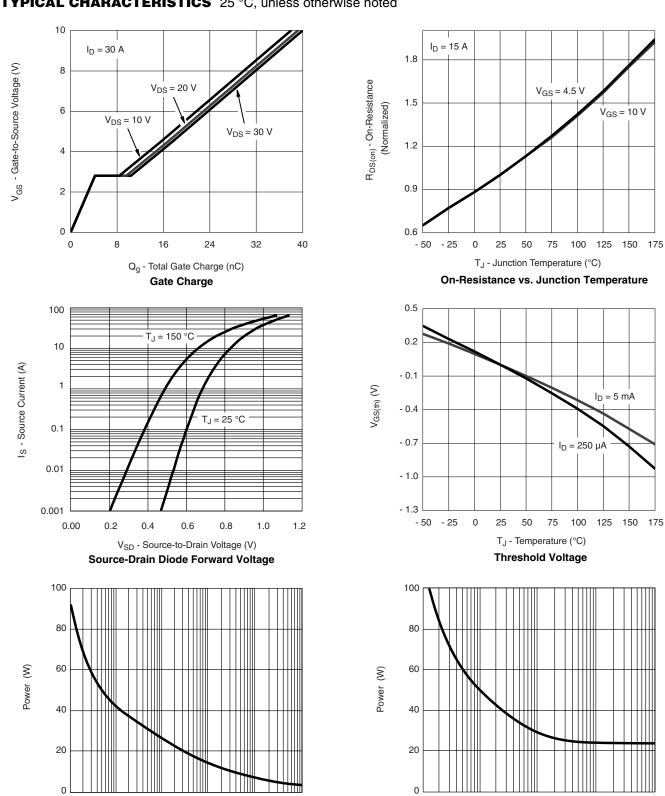


TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



0.001

0.01

0.1

1

Time (s)

Single Pulse Power, Junction-to-Ambient

10

100

10

0.01

0.001

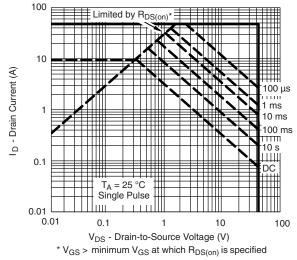
0.1

Time (s)

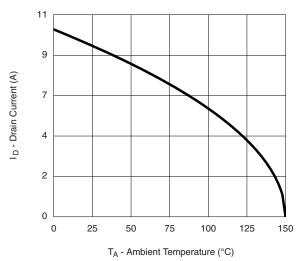
Single Pulse Power, Junction-to-Case



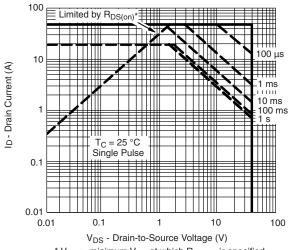
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



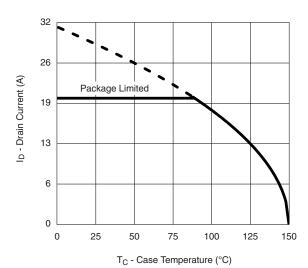
Safe Operating Area, Junction-to-Ambient



Current Derating**, Junction-to-Ambient



* V_{GS} > minimum V_{GS} at which R_{DS(on)} is specified **Safe Operating Area, Junction-to-Case**



Current Derating**, Junction-to-Case

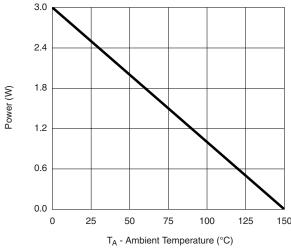
Document Number: 74477 S-81956-Rev. B, 25-Aug-08

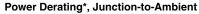
^{**} The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

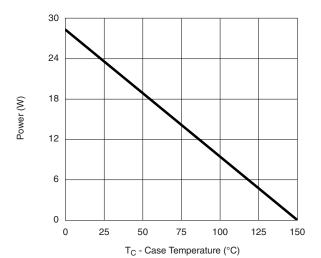
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





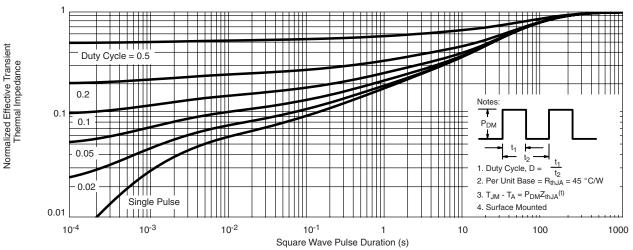


Power Derating*, Junction-to-Case

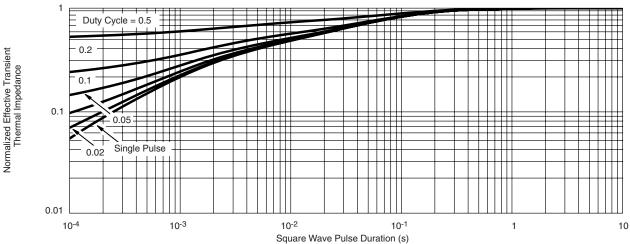
^{*} The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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